Application/Control No. 09/652,147 Examiner Kyung H Shin Applicant(s)/Patent Under Reexamination SHODA ET AL. Art Unit Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS

*	ď.	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,516,416	02-2003	Gregg et al.	713/201
	В	US-6,006,332	12-1999	Rabne et al.	713/201
	С	US-6,681,212	01-2004	Zeng, Nianning	705/51
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	υ					
	V					
	W					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.